Search Notes

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Applicant(s	)/Patent	unde
Reexaminat		

10/003,482 Examiner UR ET AL.

J. Derek Rutten 2192

SEARCHED			
Class	Subclass	Date	Examiner
717	124,126	5/25/2005	JDR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH		 )
	DATE	EXMR
East, ACM, IEEE (attached)	4/28/2005	JDR
East, IEEE (attached)	5/25/2005	JDR
Discussed finality with XP Ted Vo AU 2192	5/26/2005	JDR
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